

High Power Thyristor Hockey Puk Version B-PUK Series 1000PB

Types : 1000PB 40 to 1000PB 180

FEATURES

- ❖ Center amplifying gate.
- ❖ International standard case TO-200AC.

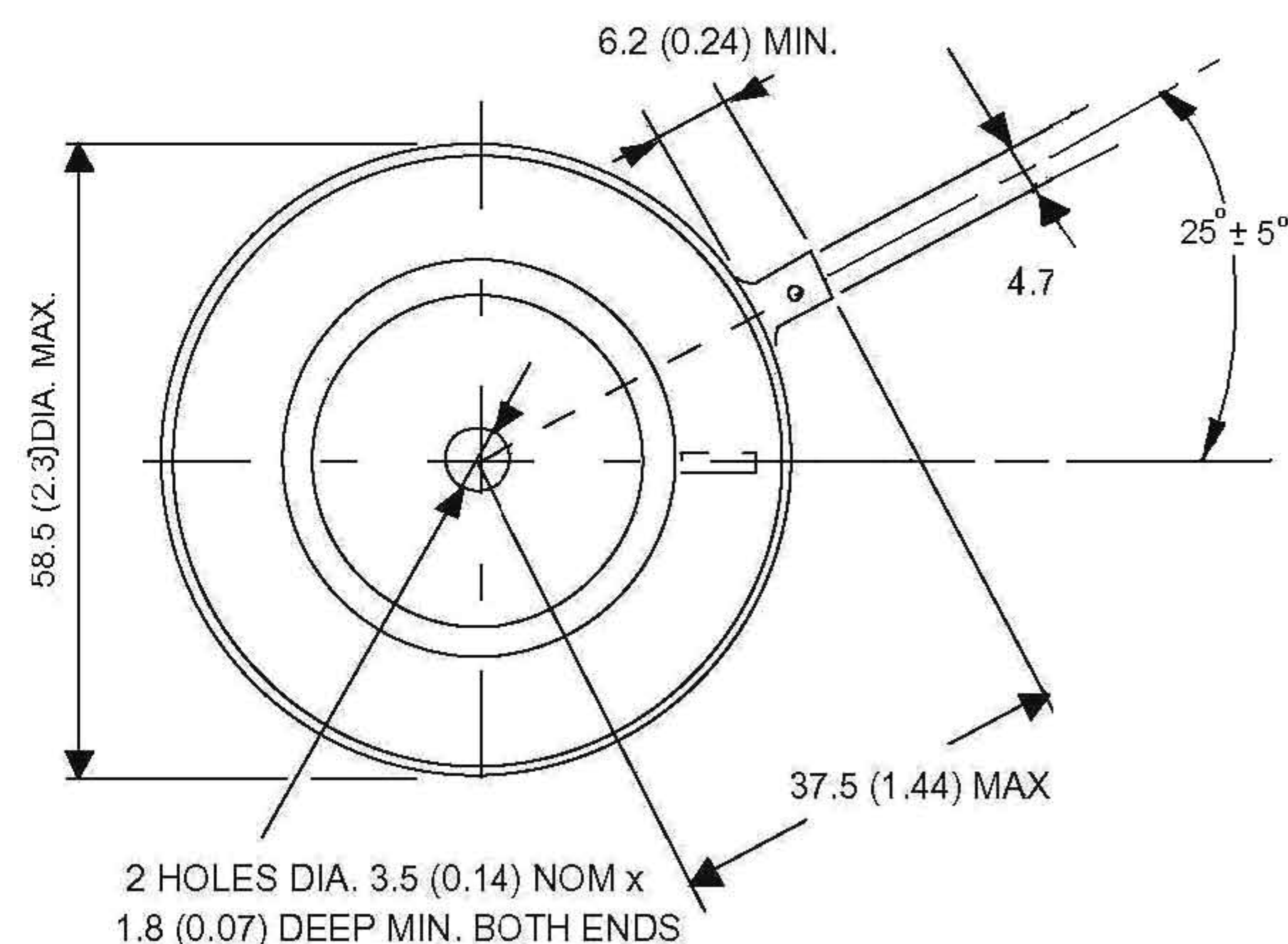
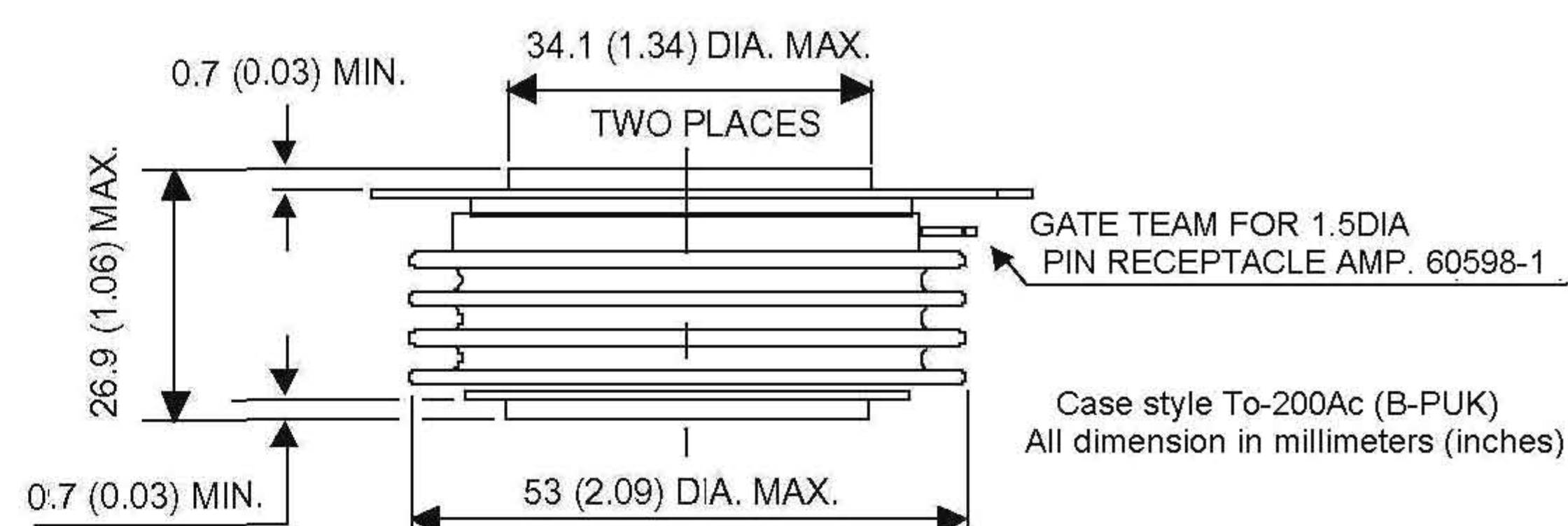
TYPICAL APPLICATIONS

- ❖ Power supply.
- ❖ Controlled rectifiers (e.g. for battery charging, UPS).
- ❖ Electroplating equipment..



MAJOR RATINGS & CHARACTERISTICS

Parameters	1000PB	Units
$I_{T(AV)}$	1000	A
@ T_{hs}	55	$^{\circ}C$
$I_{T(RMS)}$	1570	A
@ T_{hs}	55	$^{\circ}C$
I_{TSM} @ 50 Hz	17800	A
I^2t @ 50 Hz	1591	KA ² s
V_{DRM} / V_{RRM}	400 to 1800	V
t_q typical	150	μs
T_J	-40 to 125	$^{\circ}C$



CREPAGE DISTANCE 36.33 (1.430) MIN.
STRIKE DISTANCE 17.43 (0.686) MIN.

SILICON CONTROLLED RECTIFIERS

1000PB

ELECTRICAL SPECIFICATION VOLTAGE RATINGS

Type Number	Voltage Code	V_{RRM} / V_{DRM} , max. repetitive peak and off-state voltage V	V_{RSM} , max. non-repetitive peak voltage V	I_{DRM} / I_{RRM} max. @ 125°C mA
1000PB	40	400	500	80
	60	600	700	
	80	800	900	
	100	1000	1100	
	120	1200	1300	
	140	1400	1500	
	160	1600	1700	
	180	1800	1900	

ON-STATE CONDUCTION

	Parameter	1000PB	Units	Conditions	
$I_{T(AV)}$	Max. average on-state current @ heat sink temperature	1000	A	180° conduction, half sine wave double side cooled	
		55	°C		
$I_{T(RMS)}$	Max. RMS on-state current	1570	A	@55°C heat sink temperature (double side cooled)	
I_{TSM}	Max. peak one cycle non-repetitive surge current	17800		t = 10ms	Sinusodial half wave, Initial $T_J = T_J$ max.
I^2t	Maximum I^2t for fusing	1591		t = 10ms	
$I^2\sqrt{t}$	Maximum I^2t for fusing	15910	k A ² s	t = 0.1 to 10ms. No voltage reapplied.	
$V_{T(TO)}$	Threshold voltage	0.98	V	$T_J = T_J$ max.	
r_{t2}	On state slope resistance	0.52	mΩ	$T_J = T_J$ max.	
V_{TM}	Max. on state voltage	1.4	V	$I_{pk} = 1000A$, $T_J = T_J$ max., $t_p = 10ms$ sine pulse	
I_H	Maximum holding current	600	mA	$T_J = 25^{\circ}C$, anode supply 12V resistive load	
I_L	Latching current	1000			

SWITCHING

	Parameter	1000PB	Units	Conditions	
di/dt	Max. non-repetitive rate of rise of turned-on current	100	A/μs	Gate drive 20V, 20Ω, $t_r \leq 1 \mu s$ $T_J = T_J$ max., anode voltage $\leq 80\% V_{DRM}$	
t_d	Typical delay time	1.0	μs	Gate current 1A, $di_g/dt = 1A/\mu s$ $V_d = 0.67\% V_{DRM}$, $T_J = 25°C$	
t_q	Typical turn-off time	150		$I_{TM} = 750A$, $T_J = T_J$ max., $di/dt = 40A/\mu s$, $V_R = 50V$ $dv/dt = 20V/\mu s$, Gate 0V 100Ω, $t_p = 500\mu s$	

SILICON CONTROLLED RECTIFIERS

1000PB

BLOCKING

	Parameter	1000PB	Units	Conditions
dv/dt	Maximum critical rate of rise of off-state voltage	500	V/ μ s	$T_J = T_J \text{ max}$ linear to 80% rated V_{DRM}
I_{RRM} I_{DRM}	Max. peak reverse and off-state leakage current	80	mA	$T_J = T_J \text{ max}$, rated $V_{\text{DRM}}/V_{\text{RRM}}$ applied

TRIGGERING

	Parameter	1000PB		Units	Conditions
P _{GM}	Maximum peak gate power	10.0		W	T _J = T _J max., t _p ≤ 5ms
P _{G(AV)}	Maximum average gate power	2.0			T _J = T _J max., f= 50Hz, d% = 50
I _{GM}	Max. peak positive gate current	3.0		A	T _J = T _J max., t _p ≤ 5ms
+V _{GM}	Max. peak positive gate voltage	20		V	T _J = T _J max., t _p ≤ 5ms
-V _{GM}	Max. peak negative gate voltage	5.0			
I _{GT}	DC gate current required to trigger	TYP.	MAX.	mA	T _J = 25°C Max. required gate trigger/current / voltage are the lowest value which will trigger all units 12V anode-to-cathode applied.
		100	200		
V _{GT}	DC gate voltage required to trigger	1.8	3.0	V	T _J = 25°C
I _{GD}	DC gate current not to trigger	10		mA	T _J = 125°C Max. gate current / voltage not to trigger is the max. value which will not trigger any unit with rated V _{DRM} anode-to-cathode applied.
V _{GD}	DC gate voltage not to trigger	0.25		V	

THERMAL AND MECHANICAL SPECIFICATION

	Parameter	1000PB	Units	Conditions
T_J	Max. operating temperature range	-40 to 125	$^\circ\text{C}$	
T_{stg}	Max. storage temperature range	-40 to 150		
$R_{\text{thJ-hs}}$	Max. thermal resistance, junction to heat sink	0.031	K/W	DC operation double side cooled
F	Mounting force, $\pm 10\%$	14700 (1500)	N (kg)	
wt	Approximate weight	255	g	
	Case style	To - 200AC (B-PUK)		See outline

SILICON CONTROLLED RECTIFIERS

1000 PB

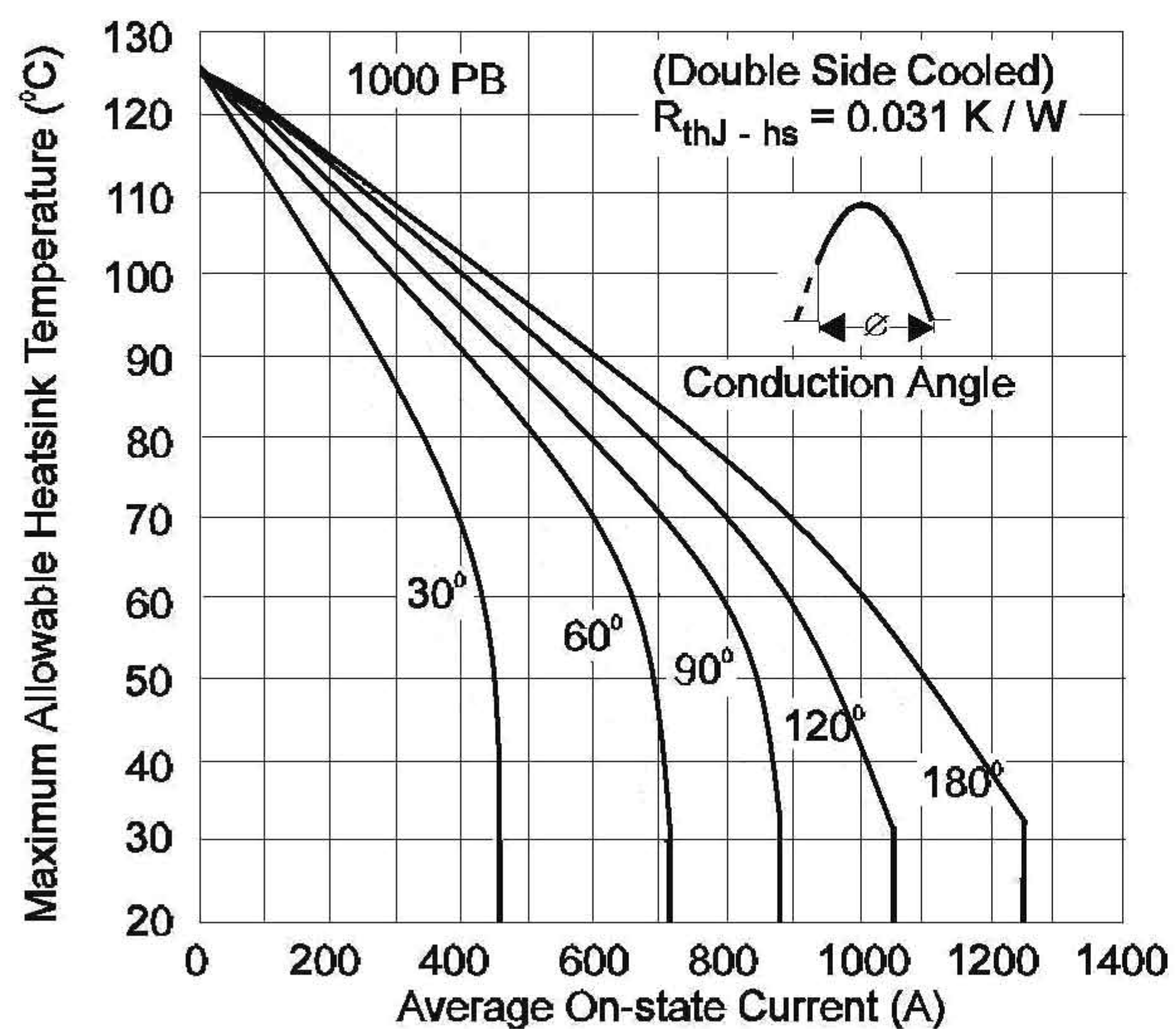


Fig. 1 - Current Ratings Characteristics

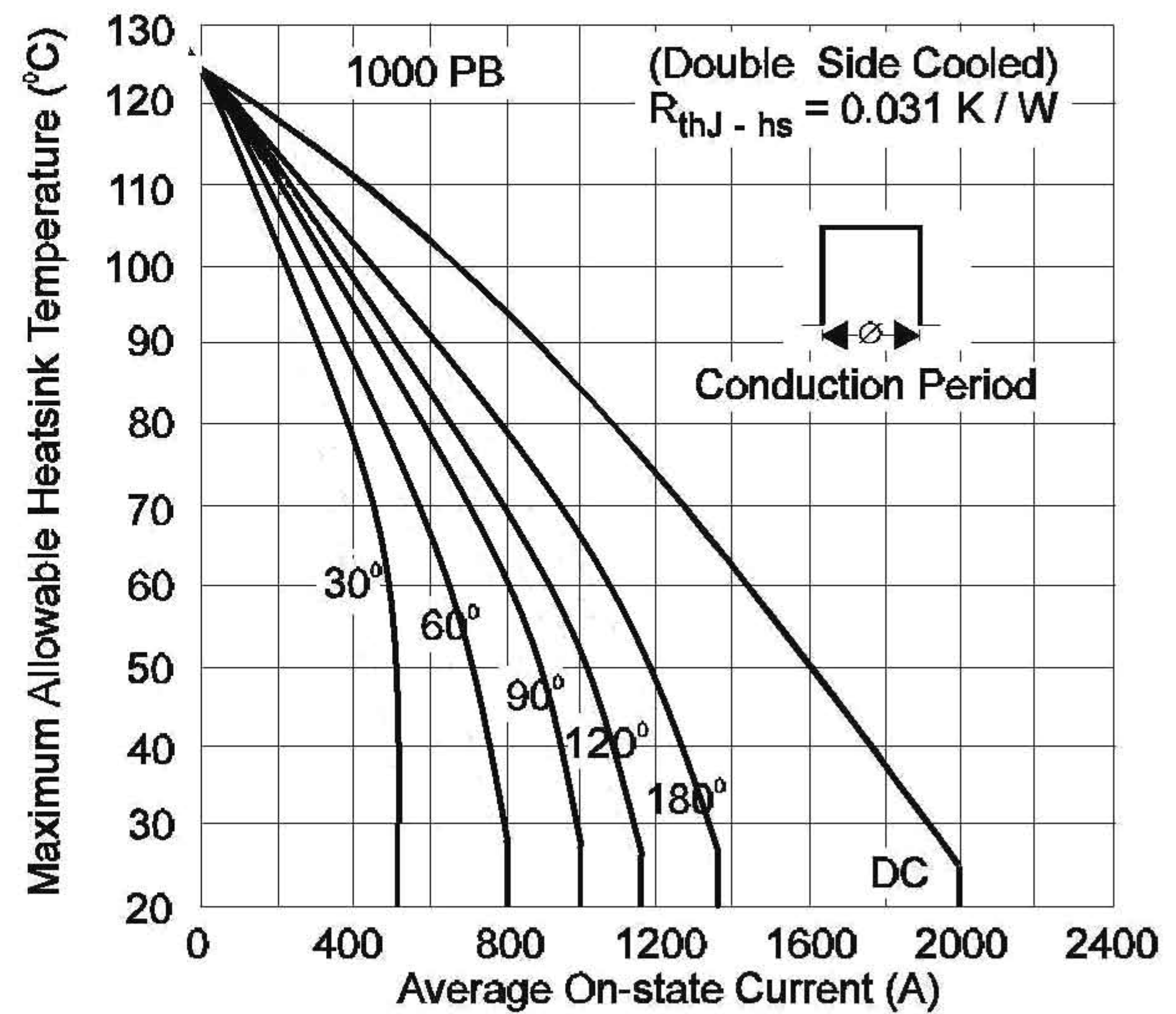


Fig. 2 - Current Ratings Characteristics

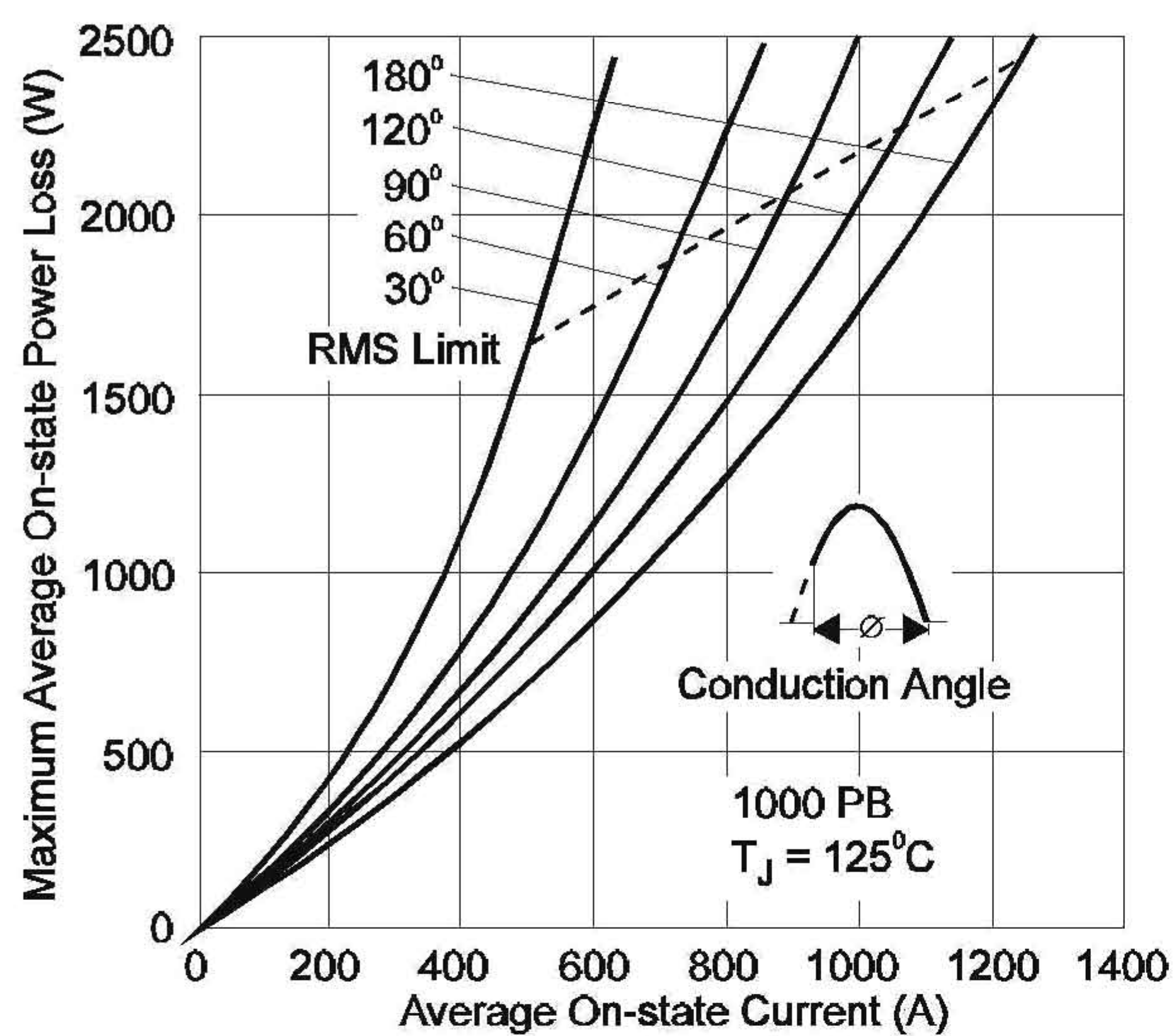


Fig. 3 - On-state Power Loss Characteristics

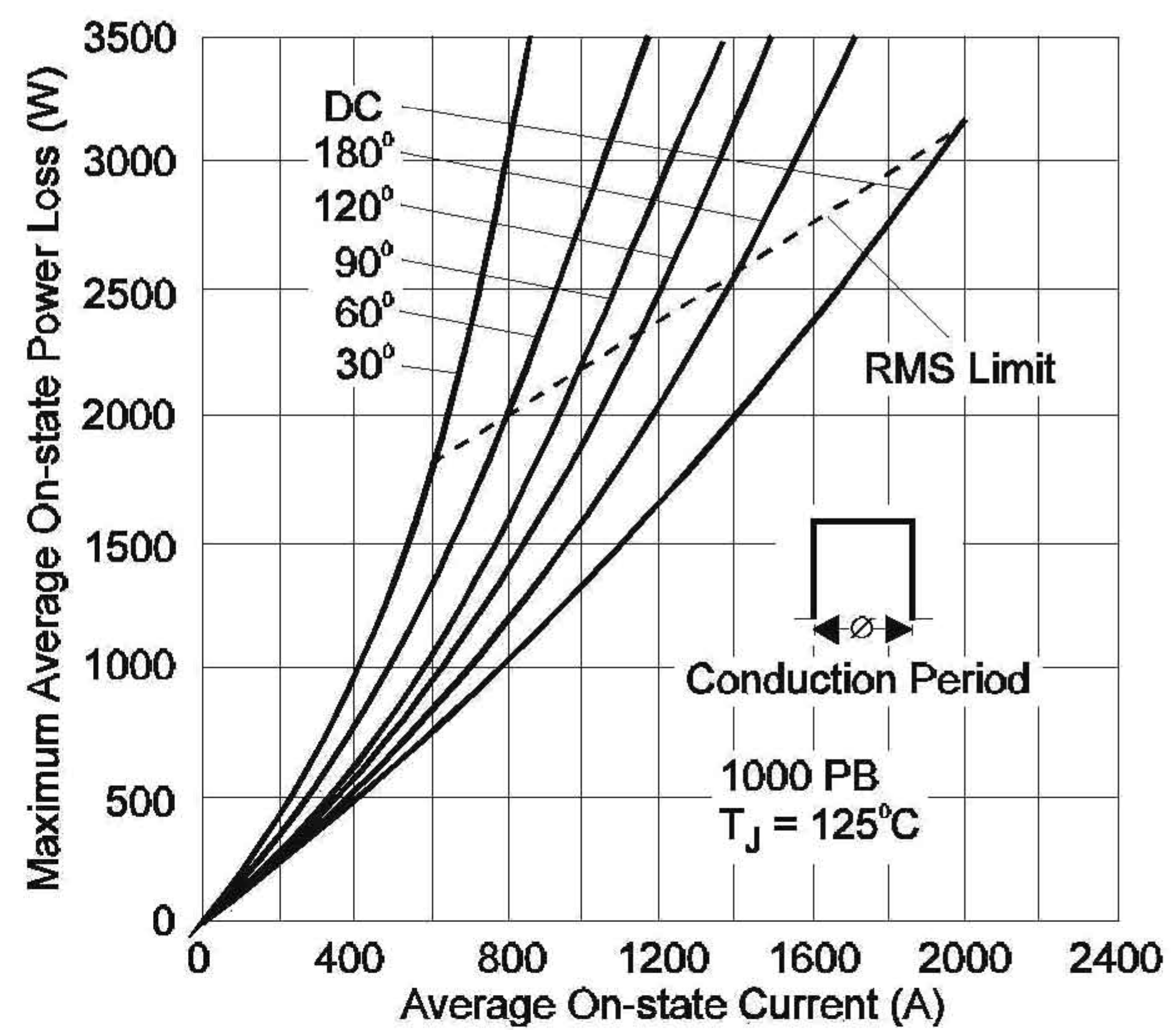


Fig. 4 - On-state Power Loss Characteristics

SILICON CONTROLLED RECTIFIERS

1000 PB

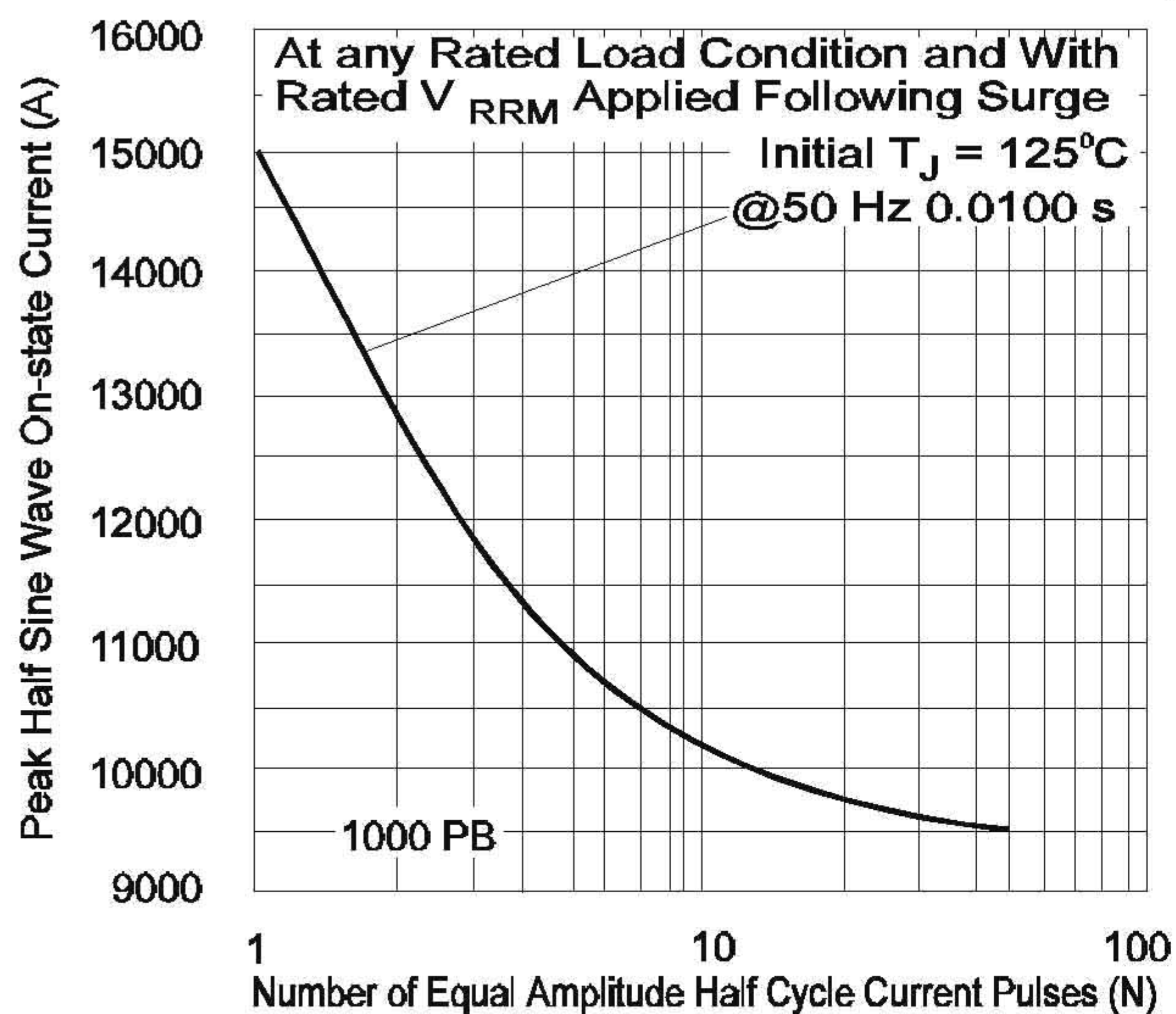


Fig. 5 - Maximum Non-Repetitive Surge Current

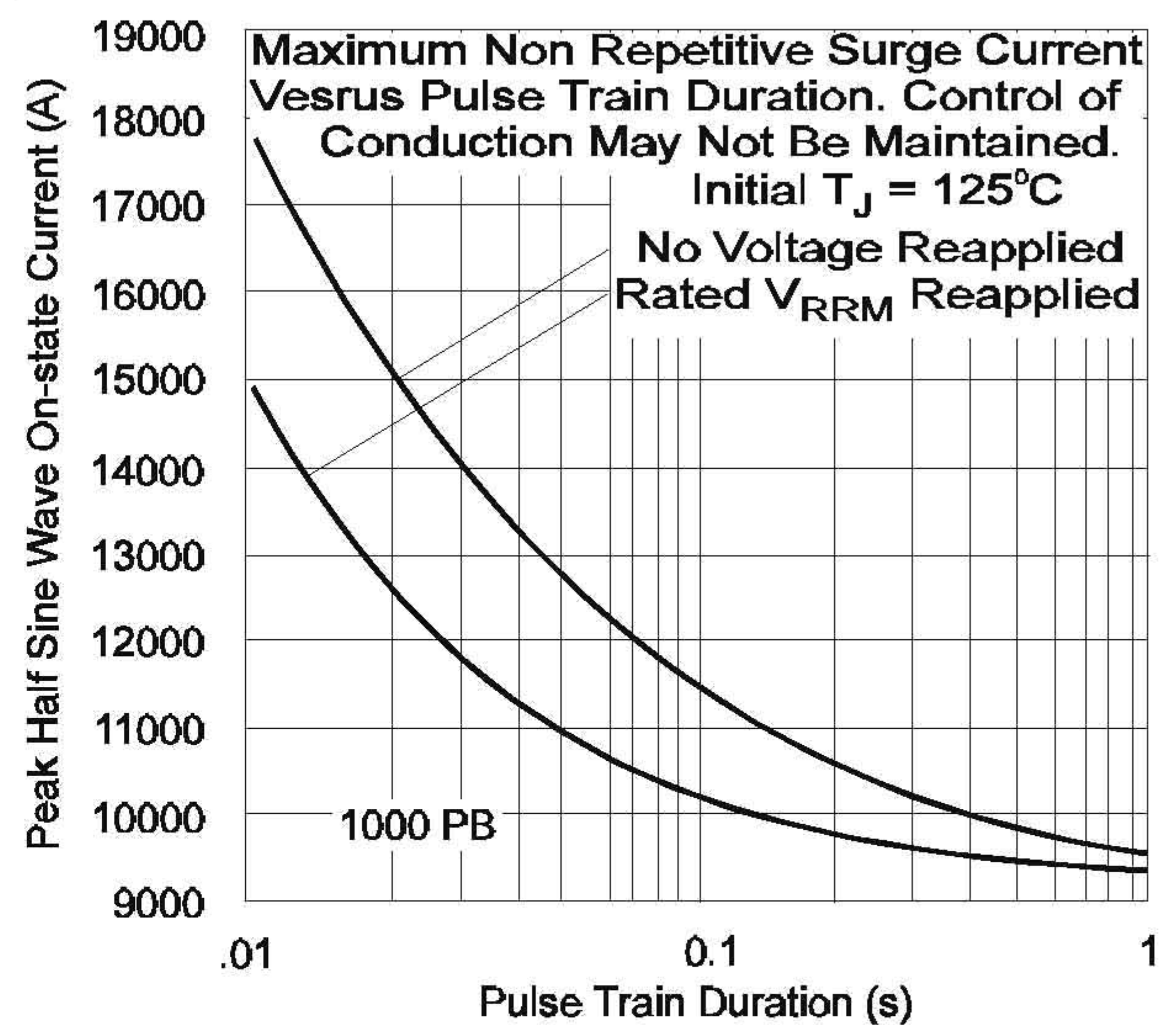


Fig. 6 - Maximum Non-Repetitive Surge Current

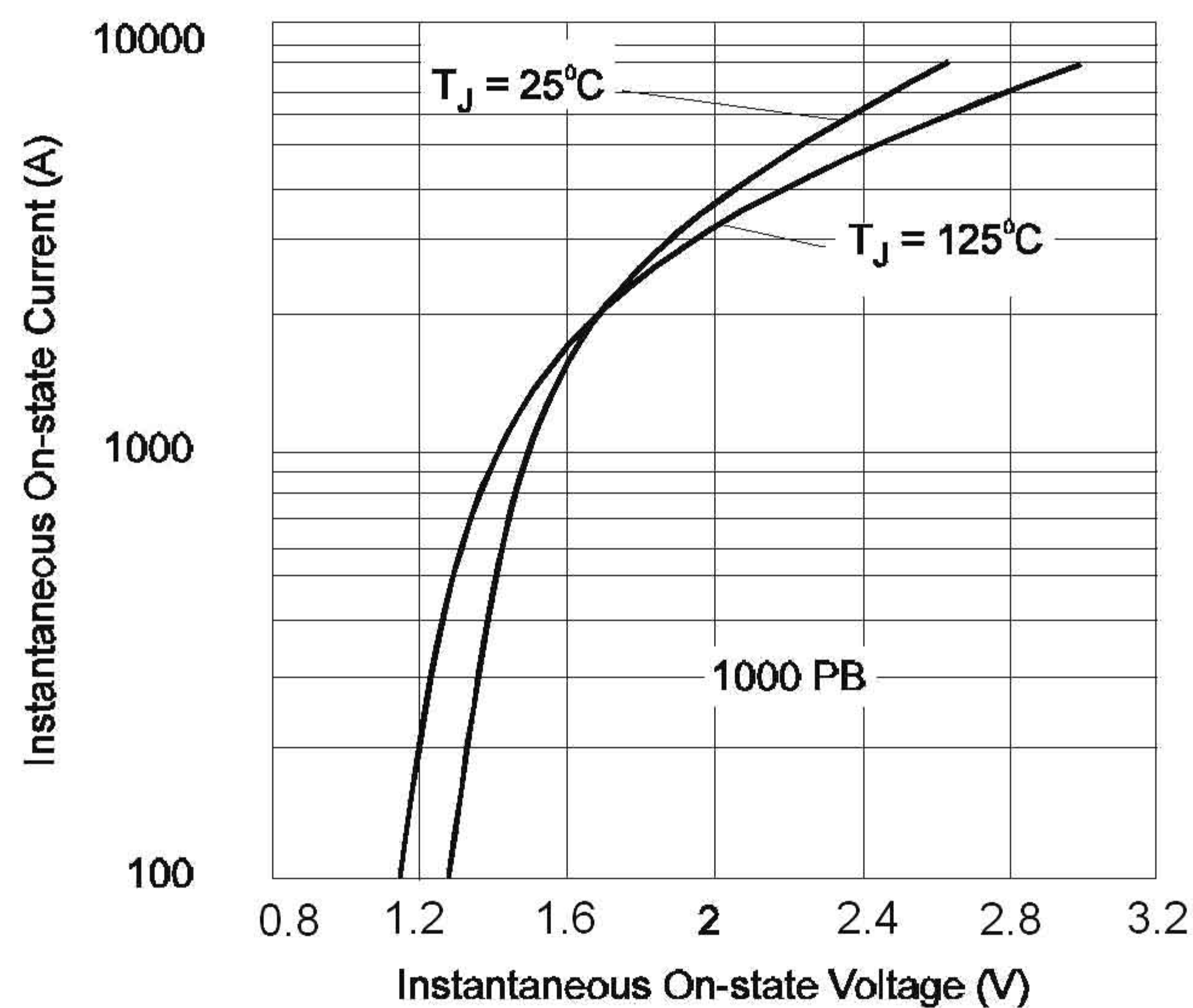


Fig. 7 - On-state Voltage Drop Characteristics

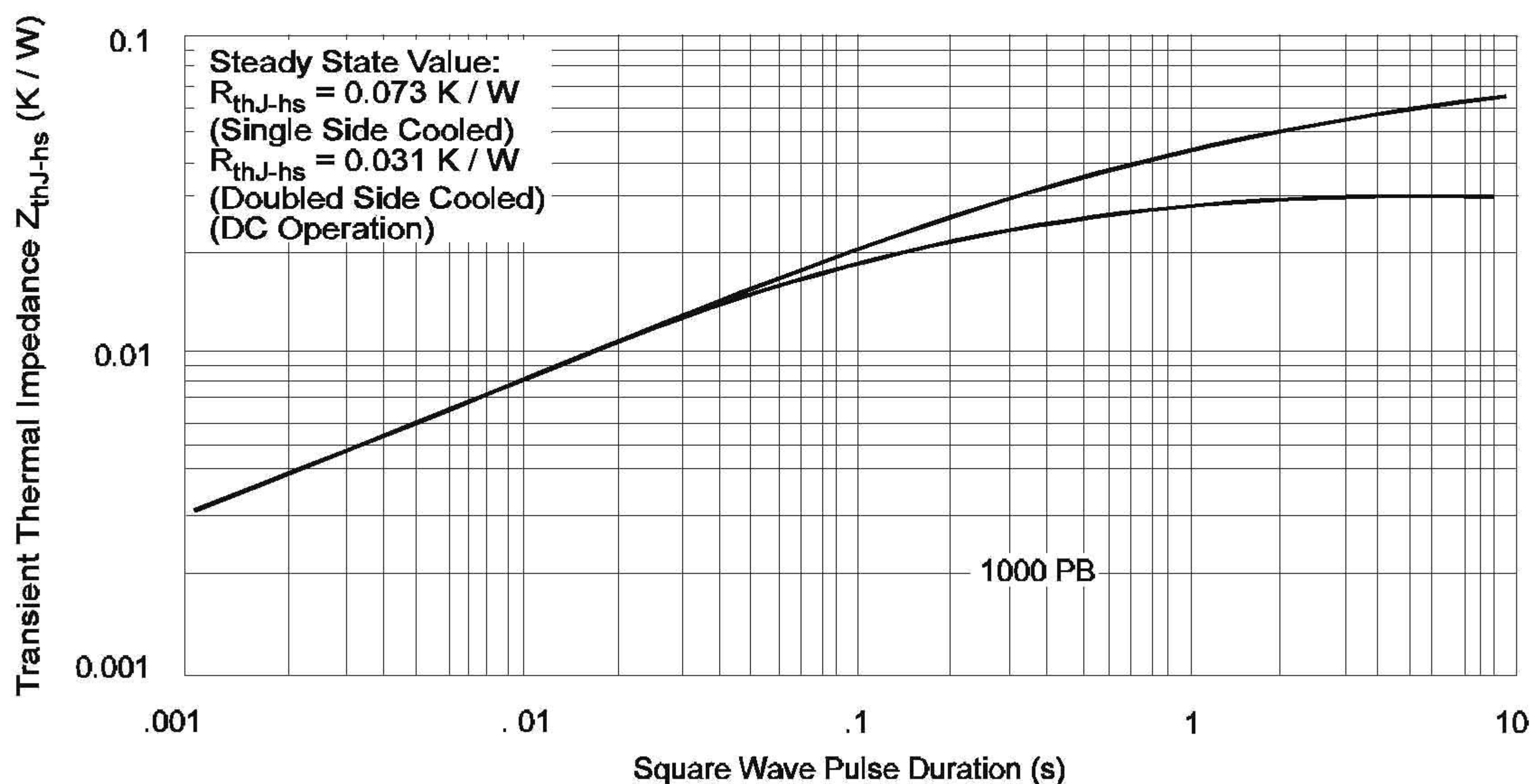


Fig. 8 - Thermal Impedance Z_{thJC} Characteristics

SILICON CONTROLLED RECTIFIERS

1000 PB

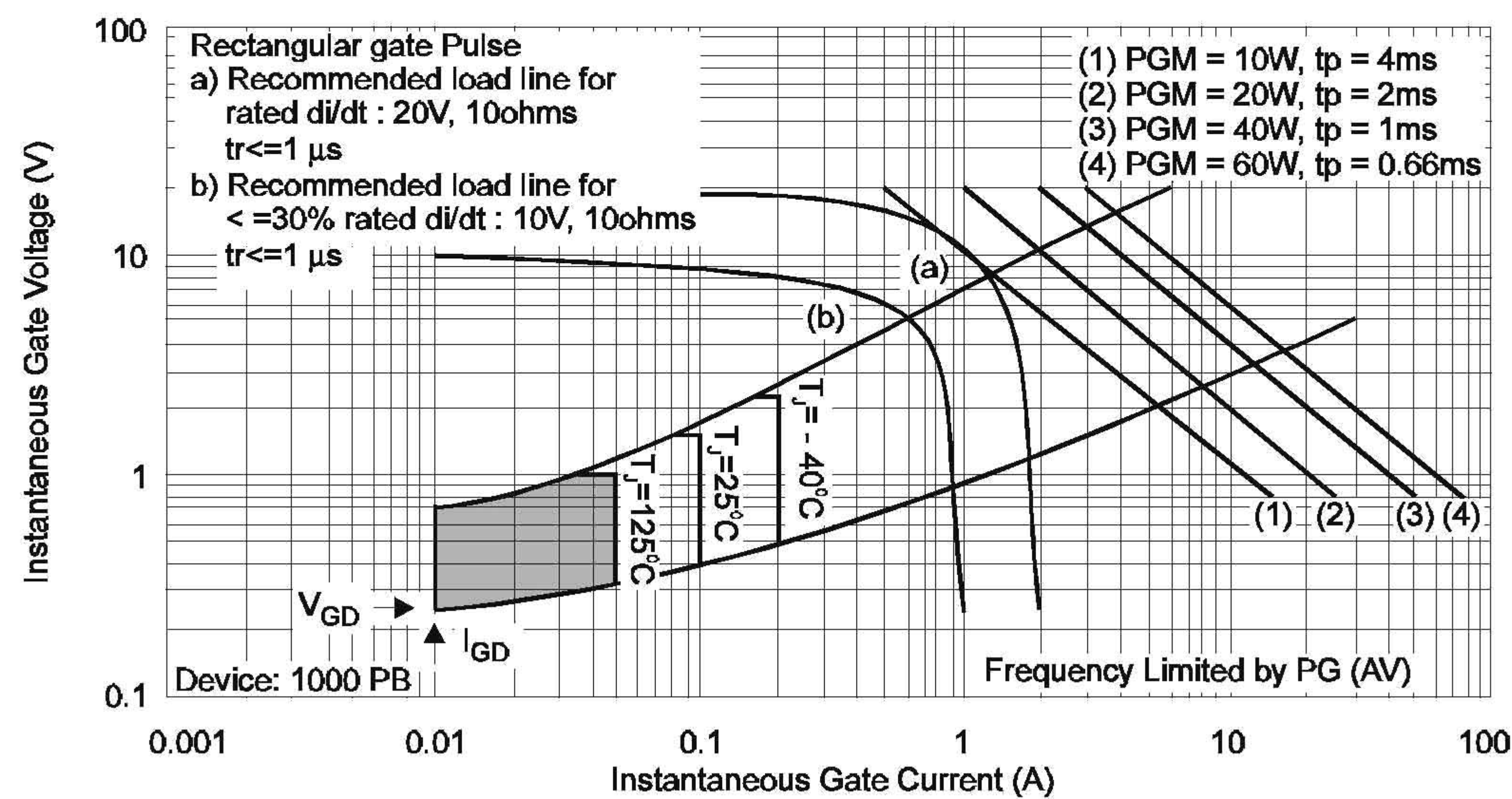


Fig. 9 - Gate Characteristics